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Ion Exchange Model for $\alpha$ Phase Proton Exchange Waveguides in LiNbO$_3$

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Abstract—An H$^+$/Li$^+$ exchange model is found to be applicable to describe the diffusion of protons when optical waveguides are formed in LiNbO$_3$ by proton exchange methods where the proton doped crystal structure stays in the pure $\alpha$ phase. The H$^+$ and Li$^+$ self-diffusion coefficients in the ion exchange model are determined as a function of the proton exchange temperature both for $x$-cut and $z$-cut LiNbO$_3$. In this way a very useful tool for predicting the proton concentration profiles and hence the refractive index profiles of $\alpha$ phase proton exchange LiNbO$_3$ waveguides is achieved.

Index Terms—Diffusion processes, modeling, optical waveguides.

I. INTRODUCTION

THE proton exchange (PE) method [1] has been used for several years to form optical waveguides at the surface of LiNbO$_3$ crystals. Exchanging lithium ions with protons in a proton source such as benzoic acid, typically at temperatures of $T = 200$ °C, induces an increase of the LiNbO$_3$ extraordinary phase region can be estimated by an H$^+$/Li$^+$ and C.

are the self-diffusion coefficients for the and phase induced $\alpha$-cut LiNbO$_3$ in the following way. The PE optical waveguides are formed in LiNbO$_3$ by a method such as DMPE. Detailed knowledge of these diffusion properties is an important tool for the optimization of optical waveguide design.

II. ION EXCHANGE MODEL

While the general description of proton diffusion in waveguides made by PE is a complicated task, related to the seven different crystal phases that can be induced [2], we assume that the protonic diffusion in PE LiNbO$_3$ staying in the pure $\alpha$ phase region can be estimated by an H$^+$/Li$^+$ exchange model [16]–[18]. Assuming this to be correct, the proton concentration profile can be found by solving the diffusion equation with a proton concentration dependent diffusion coefficient. In the case of planar waveguides the one-dimensional (1-D) diffusion equation then is [16]

$$\frac{dc}{dt} = \frac{d}{dx} \left( \frac{D_H}{1 - (1 - \frac{D_H}{D_{Li}}) c} \right)$$

where $D_H$ and $D_{Li}$ are the self-diffusion coefficients for the protons and lithium ions, respectively. The quantity $x$ is waveguide depth position whereas $t$ is the exchange time. $D_H$ and $D_{Li}$ are expected to follow an exponential activation law of the form $D_i(T) = D_{\infty i} \exp(-E_{a i}/T), i = H, Li$. Having determined $D_H(T)$ and $D_{Li}(T)$, (1) then can be solved at any temperature to predict the induced proton concentration profile for waveguides in the $\alpha$ phase region. In the case of channel waveguide formation the corresponding two-dimensional (2-D) diffusion equation can be applied if the self-diffusion coefficients are determined for both $x$- and $z$-cut planar PE waveguides.

III. EXPERIMENTAL

We have estimated experimentally $D_H(T)$ and $D_{Li}(T)$ from annealing treatments of PE planar waveguides both made in $x$- and $z$-cut LiNbO$_3$ in the following way. The PE optical waveguides were fabricated in an exchange melt consisting of 1 g KHSO$_4$ dissolved in 100 mL glycerol [19] at an exchange temperature of $T = 230$ °C. The exchange times were 2.5
h (x-cut) and 6 h (z-cut). Different waveguides were then annealed in air at temperatures in the range $T = 280-375$ °C. This was done to diffuse the protons deeper into the crystal to obtain the $\alpha$ phase structure there. For each annealed PE waveguide the annealing treatment was divided into several steps. Between each annealing step the optical waveguide mode indexes were measured with a prism coupler setup at the 632.8 nm wavelength (in the following the optical properties discussed of the LiNbO$_3$ waveguides are at 632.8 nm and the refractive index always refers to the extraordinary refractive index). From the measured mode indexes, the profile of the refractive index was estimated by the inverse WKB method by White et al. [20]. To have some approximate relation between the change of the refractive index ($\Delta n$) and the proton concentration, the expression suggested in [9], based on the structural behavior of powder LiNbO$_3$ with proton concentration [21], was found to give fairly consistent results in our calculations

$$c \leq 0.12: \Delta n(c) = 0.1623c$$

$$0.12 < c \leq 0.56: \Delta n(c) = -0.2656c^2 + 0.3636c - 0.0203$$

$$c > 0.56: \Delta n(c) = 0.0833c + 0.0533.$$

Using this relation both for $x$- and $z$-cut LiNbO$_3$, the proton concentration before and after each annealing step thus could be determined. The values of $D_H$ and $D_L$ for a certain temperature were then obtained as follows. For each annealing step (1) was used to calculate the proton concentration profile after this annealing step. When solving (1) the measured concentration profile before the annealing step was used as the initial proton profile. The calculated and measured proton profile after the annealing step were then compared via the expression

$$S = \frac{1}{N} \sum_{i=0}^{N-1} \frac{c(x_i) - \hat{c}(x_i))^2}{\alpha(x_i)^2}.$$

The quantities $c(x_i)$ and $\hat{c}(x_i)$ are the measured and calculated proton concentrations taken in a number $N$ of equally spaced waveguide depth positions $x_i$. For each annealing temperature the values of $D_H$ and $D_L$ were determined by minimizing $S$ averaged over all annealing steps.

The main advantage of using APE waveguides to determine $D_H$ and $D_L$, is that it is easy to achieve waveguides with many modes over a relatively large temperature interval. Therefore, detailed information on the waveguide proton concentration profile from mode index measurements can be obtained in this temperature interval. Though a more complicated description than a simple ion exchange model must be included when describing the formation of the PE waveguides formed with the above mentioned conditions [22], we prefer to calculate the $\alpha$ phase self-diffusion coefficients from the corresponding APE waveguides as a simple approximation assuming that diffusion mainly takes place as in the $\alpha$ phase. This approximation is probably good since the waveguides contained regions with relatively low proton concentrations and since the function in (3) due to the weight parameter $\alpha(x_i)^2$ emphasizes the $\alpha$ phase region where $\alpha(x_i)^2$ is small.

The values determined for $D_H$ and $D_L$ as a function of temperature are shown by the dots in Fig. 1 and compared to the expected $D(T) = D_{\infty,i} \exp(-E_{\alpha,i}/T)$, $i = H$, Li, dependence. The agreement is excellent. Hence, the diffusion model in (1) seems to be confirmed. From the data shown in Fig. 1, the values of $D_{\infty,H}$ and $T_{\alpha,H}$ were determined to be $D_{\infty,H} = \exp(18.82) \mu m^2/h$, $T_{\alpha,H} = 10.92 \cdot 10^3 K$ and $D_{\infty,Li} = \exp(23.05) \mu m^2/h$, $T_{\alpha,Li} = 15.93 \cdot 10^3 K$ for $x$-cut LiNbO$_3$. For $z$-cut LiNbO$_3$ the values were determined to be $D_{\infty,H} = \exp(22.99) \mu m^2/h$, $T_{\alpha,H} = 13.17 \cdot 10^3 K$ and $D_{\infty,Li} = \exp(22.11) \mu m^2/h$, $T_{\alpha,Li} = 15.32 \cdot 10^3 K$.

To further verify the ion exchange model with the self-diffusion coefficients determined by the above described procedure, we calculated the proton concentration profile and
Fig. 2. Experimentally determined refractive index profile for a $z$-cut GPE waveguide (dots) taken from [11] and calculated profile using (1) [solid curve].

Fig. 3. Calculated and measured dependence of fundamental mode refractive index on exchange time for $z$-cut waveguides formed by the DMPE method in [9].

IV. SUMMARY

In conclusion, it can be stated that we have shown that it is possible to use an H$^+$/Li$^+$ exchange model to describe the diffusion of protons in waveguides with proton concentrations that correspond to the $\alpha$ phase, when these waveguides are formed in LiNbO$_3$ either by the graded proton exchange or the dilute melt proton exchange method. The values of the proton and lithium self-diffusion coefficients have been determined as a function of temperature for $x$- and $z$-cut LiNbO$_3$. In this way any $\alpha$ phase proton profile of proton exchange planar or channel optical waveguides in LiNbO$_3$ can be predicted at any fabrication temperature. This is an extremely useful tool in the optimization procedure of the optical properties of $\alpha$ phase waveguide designs.

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hence the refractive index profile of a waveguide in $z$-cut LiNbO$_3$ from [11] fabricated by GPE at an exchange temperature of $T = 400$ $\degree$C, The experimentally determined profile of the refractive index is taken from Fig. 8 in [11] and is shown here by the dots in Fig. 2. The solid line shown in this figure is the refractive index profile calculated from the ion exchange model with the values determined for $D_H(T)$ and $D_L(T)$ at $T = 400$ $\degree$C using the parameters found above. The diffusion equation was solved assuming that the value of the proton concentration at the LiNbO$_3$ crystal surface is kept constant during the exchange process.

We also applied the ion exchange model to DMPE optical waveguides. The waveguides were made in $z$-cut LiNbO$_3$ by the DMPE method from [9] using a system of glycerol, KHSO$_4$ and lithium benzoate at an exchange temperature of $T = 230$ $\degree$C, Fig. 3 shows how the fundamental waveguide mode index $\beta$ evolves with the exchange time. The values of the mode index $\beta$, determined experimentally from prism coupler measurements, are shown by the points while the solid lines represent the values of $\beta$ determined from the proton profile solution obtained from (1) at $T = 230$ $\degree$C. The error bars in Fig. 3 are the uncertainty in the mode index determination using the prism coupler, the value estimated to be $\pm 0.0003$. When solving the diffusion equation it was assumed that the surface refractive index and hence surface proton concentration is kept constant during the exchange process. The two curves correspond to different exchange melt compositions which determine the surface refractive index change $\Delta n_S$. The calculated refractive index profile was subdivided into a number of step layer profiles, and the method by Offerzaard [23] was then used for calculating $\beta$. In the calculation of $\beta$ it was assumed that the ratio between the ordinary and extraordinary refractive index change was $\approx 0.32$ [23]. Both in Figs. 2 and 3, we see a very good agreement between experimental data and predicted data using (1) for, respectively, GPE and DMPE waveguides.

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